

<b>Notice of References Cited</b>	Application/Control No. 10/506,531		Applicant(s)/Patent Under Reexamination UGAI ET AL.	
	Examiner Maria Veronica D. Ewald		Art Unit 1722	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,762,967	06-1998	Sagawa et al.	425/3
*	B	US-3,663,147	05-1972	Maekawa et al.	425/345
	C	US-			
	D	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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